Application/Control No.	Applicant(s)/Patent under Reexamination
10/694,117	CHEN ET AL.
Examiner	Art Unit

William Boddie

2629

	SEARCHED				
Class	Subclass	Date	Examiner		
345	98-100	5/8/2006	WLB		
377	64-100	5/8/2006	WLB		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East Search See attached Search History	5/8/2006	WLB
Consulted with A. Awad	5/8/2006	WLB
Updated Search	10/5/2006	WLB